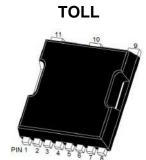


Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low RDS(ON)

Applications

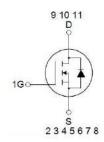
- DC-DC Converters
- Power management functions
- Synchronous-rectification applications



Product Summary



VDS	40	V
RDS(on),max.@ VGS=10V	1.5	mΩ
ID	200	Α



■ Absolute Maximum Ratings (T_A=25 °C unless otherwise noted)

Parameter		Symbol	Limit	Unit	
Drain-source Voltage		V _{DS}	40	V	
Gate-source Voltage		V_{GS}	±20	V	
Drain Current (Silicon limited)		Ι _D	225	A	
Drain Current ^A	T _c =25℃	- I _D	200	- А	
	T _c =100℃		82		
Pulsed Drain Current ^B		I _{DM}	600	А	
Avalanche energy ^C		Eas	450	mJ	
Total Power Dissipation ^D		P _D	114	W	
Thermal Resistance Junction-to-Case		R _{eJC}	1.1	- ℃/ W	
Thermal Resistance Junction-to-Ambient ^E		R _{eJA}	20		
Junction and Storage Temperature Range		T_J , T_STG	-55∼+150	$^{\circ}$ C	



■ Electrical Characteristics (T_J=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Тур	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	40			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V,V _{GS} =0V			1	μΑ
Gate-Body Leakage Current	I _{GSS}	V_{GS} = ± 20 V, V_{DS} =0V			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V_{DS} = V_{GS} , I_D =250 μ A	1.2		2.5	V
		V _{GS} = 10V, I _D =20A			1.5	- mΩ
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} = 4.5V, I _D =20A			2.3	
Gate Resistance	R _g	V _{GS} =0V,V _{DS} Open,f=1MHZ		2.7		Ω
Maximum Body-Diode Continuous Current	Is				200	Α
Dynamic Parameters			-1	1		ı
Input Capacitance	C _{iss}	V _{DS} =25V,V _{GS} =0V,f=300KHZ		8300		pF
Output Capacitance	C _{oss}			1510		
Reverse Transfer Capacitance	C _{rss}			130		
Switching Parameters			- 1	1		I
Total Gate Charge	Q_g			127		
Gate-Source Charge	Q _{gs}	V_{GS} =10V, V_{DS} =32V, I_{D} =20A		35		
Gate-Drain Charge	Q_{gd}			26		- nC
Reverse Recovery Chrage	Q _{rr}	1 -25 A di/dt-100 A (vo		163		
Reverse Recovery Time	t _{rr}	I _F =25A, di/dt=100A/us		100		
Turn-on Delay Time	t _{d(on)}	V _{GS} =10V,V _{DD} =20V,I _D =25A		22.5		
Turn-on Rise Time	t _r			6.7		ns
Turn-off Delay Time	t _{d(off)}	$R_{GEN}=2\Omega$		80.3		
Turn-off fall Time	t _f			26.9		

Note:

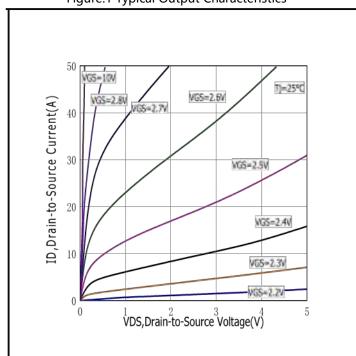
- A. The maximum current rating is package limited.
- B. Repetitive rating; pulse width limited by max. junction temperature.
- C. V_{DD} =32 V, R_G =25 Ω , L=0.5mH, starting T_j =25 $^{\circ}$ C.
- D. P_D is based on max. junction temperature, using junction-case thermal resistance.
- E. The value of R_{BJA} is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with Ta=25 °C.



Typical Performance Characteristics

Figure.1 Typical Output Characteristics

Figure.2 Typical Gate Charge vs Gate to Source Voltage



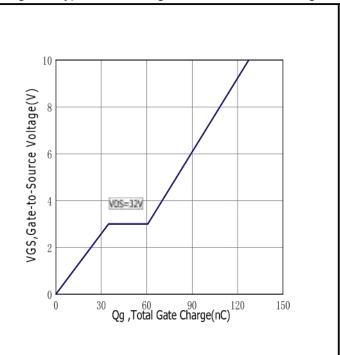


Figure.3 Typical Body Diode Transfer Characteristics

10000 9000 100000 100000 100000 100000 100000 10000 10000 10000 10000 10000 10000 10000 10000 10000 10000 10

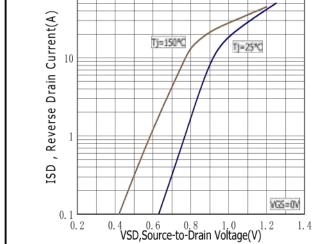


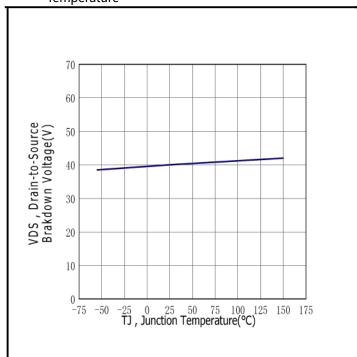
Figure.4 Typical Capacitance vs Drain to Source Voltage



Typical Performance Characteristics

Figure.5 Typical Breakdown Voltage vs Junction Temperature

Figure.6 Typical Drain to Source on Resistance vs Junction Temperature



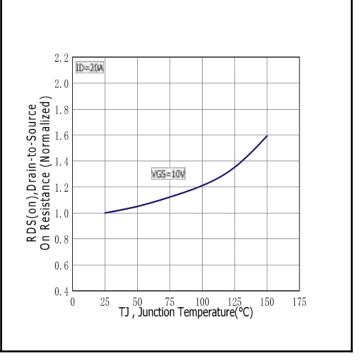
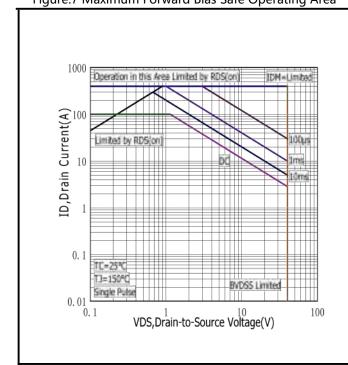
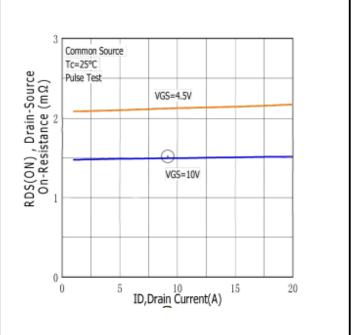


Figure.7 Maximum Forward Bias Safe Operating Area

Figure.8 Typical Drain to Source ON Resistance vs Drain

Current







Typical Performance Characteristics

Figure.10 Typical Threshold Voltage vs Case Temperature

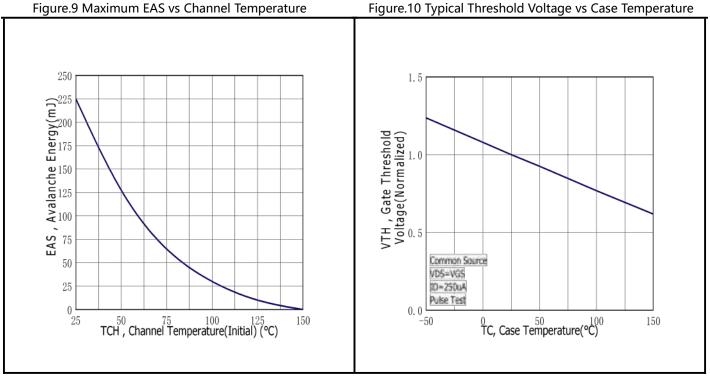
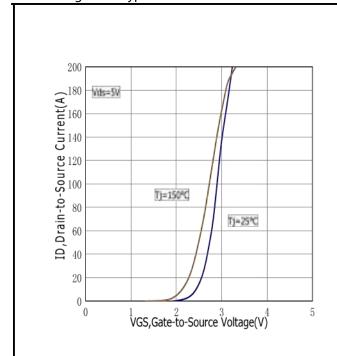
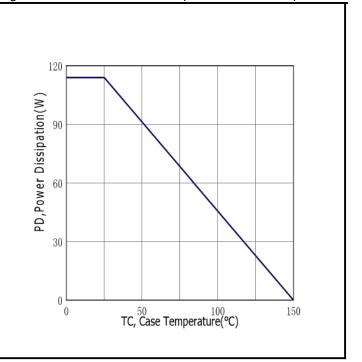


Figure.11 Typical Transfer Characteristics

Figure.12 Maximum Power Dissipation vs Case Temperature







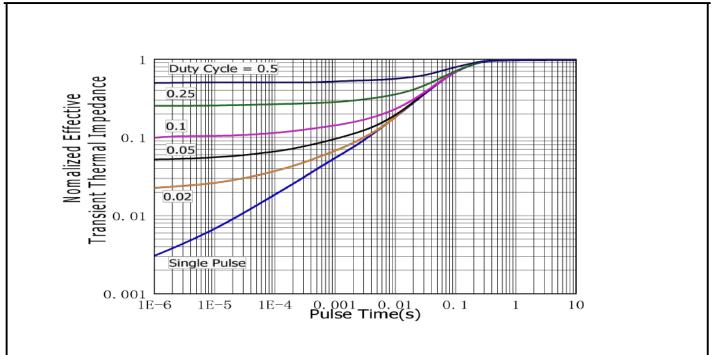


Figure.13 Maximum Effective Thermal Impedance, Junction to Case



Test circuits and waveforms

Figure A: Gate Charge Test Circuit & Waveforms

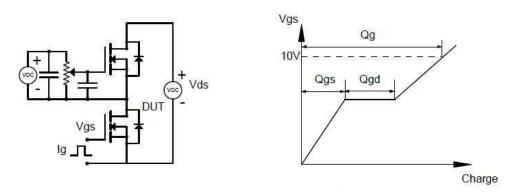


Figure B: Resistive Switching Test Circuit & Waveforms

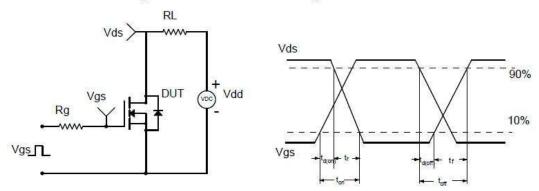


Figure C: Unclamped Inductive Switching (UIS) Test

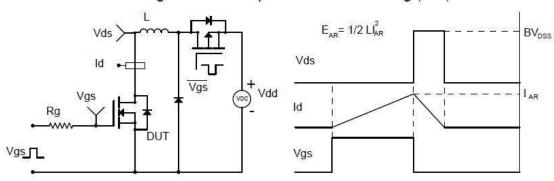
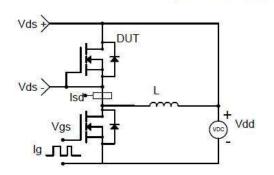
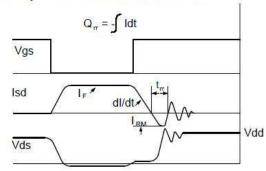


Figure D: Diode Recovery Test Circuit & Waveforms







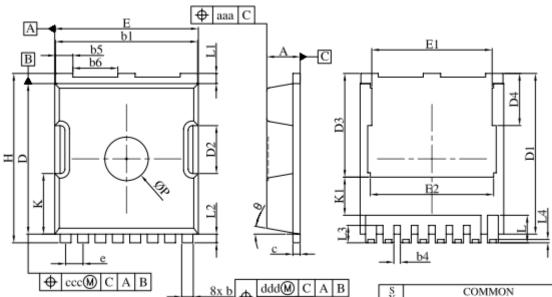
Ordering and Marking Information

Ordering Device No.	Marking	Package	Packing	Quantity
ASDM40R015NT-R	40R015N	TOLL	Tape&Reel	2000/Reel

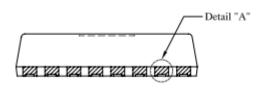
PACKAGE	MARKING	
TOLL	AS	

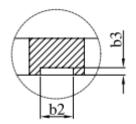


TOLL



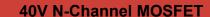
eeeM C





S	COMMON			
M B O	MILLIMETER			
Ľ	MIN.	NOMINAL	MAX.	
Α	2.20	2.30	2.40	
b	0.70	0.80	0.90	
bl	9.70	9.80	9.90	
Ь2	0.36	0.45	0.55	
b3	0.05	0.100	0.35	
Ъ4	0.30	0.40	0.50	
b5	1.10	1.20	1.30	
b6	3.00	3.10	3.20	
С	0.40	0.50	0.60	
D	10.28	10.38	10.55	
D1	10.98	11.08	11.18	
D2	3.20	3.30	3.40	
D3	7.00	7.15	7.30	
D4	3.44	3.59	3.74	
е	1.10	1.20	1.30	
Е	9.80	9.90	10.00	
El	8.20	8.30	8.40	
E2	8.35	8.50	8.65	
Н	11.50	11.68	11.85	
K	4.08	4.18	4.28	
K1	2.45			
L	1.60	1.90	2.10	
Ll	0.50	0.70	0.90	
L2	0.50	0.60	0.70	
L3	1.00	1.20	1.30	
L4	0.13	0.23	0.33	
P	2.85	3.00	3.15	
θ	10° REF			
aaa	0.20			
ccc	0.20			
ddd	0.25			
eee		0.20		







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